Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,603	AKASHE ET AL.	
Examiner	Art Unit	
Anthony Weier	1761	

	SEAR	CHED	
Class	Subclass	Date	Examiner
426	656, 634, 574, 583	12/22/2005	AW
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INT	ERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

	CH NOTES EARCH STRATEGY	′)
	DATE	EXMR
Inventor Search	12/22/2005	AW